



Nd:YLF - Neodymium Doped Yttrium Lithium Fluoride (Nd:YLiF₄)

Introduction

CASTECH grows Nd:YLF crystals using Czochralski method. The use of high quality starting materials for crystal growth, whole boule interferometry, and precise inspection of scattering particle in crystal using He-Ne laser assure that each crystal will perform well.

CASTECH's general Nd:YLF production capabilities including

- Rod sizes from 2 mm to 10 mm in diameter and from 1 mm to 150 mm in length
- Orientation of rod axis to crystal axis <1 degree
- Polished only or AR coated rods
- Nd dopant concentrations between 0.4 and 1.2 at%
- Large rod and slab dimensions and non-standard dopant concentrations are available upon request

Table 1. Basic Properties

Chemical Formula	LiY _{1.0-x} Nd _x F ₄
Crystal Structure	Tetragonal
Space Group	I4 ₁ /a
Nd atoms / cm ³	1.40 × 10 ²⁰ atoms/cm ³ for 1% Nd doping
Modulus of Elasticity	85 GPa
Lattice Parameter	a = 5.16 Å, c = 10.85 Å
Melting Point	819°C
Mohs Hardness	4~5 Mohs
Density	3.99 g/cm ³
Thermal Conductivity	0.063 W/cm/K
Specific Heat	0.79 J/g/K
Thermal Expansion Coefficient	8.3 × 10 ⁻⁶ /K // c, 13.3×10 ⁻⁶ /K ⊥ c



Table 2. Optical Properties

Transparency Range	180-6700 nm
Peak Stimulated Emission Cross Section	$1.8 \times 10^{-19} \text{ cm}^2 (\text{E} \parallel \text{c})$ at 1047 nm $1.2 \times 10^{-19} \text{ cm}^2 (\text{E} \perp \text{c})$ at 1053 nm
Fluorescence Lifetime	485 μs for 1% Nd doping
Scatter Losses	<0.2% /cm
Peak Absorption Coefficient (for 1.2% Nd)	$\alpha = 10.8 \text{ cm}^{-1}$ (792.0 nm $\text{E} \parallel \text{c}$) $\alpha = 3.59 \text{ cm}^{-1}$ (797.0 nm $\text{E} \perp \text{c}$)
Laser Wavelength	1047 nm ($\parallel \text{c}$, a-cut crystal) 1053 nm ($\perp \text{c}$, a or c-cut crystal)
Sellmeier Equations (λ in μm):	$n_o^2 = 1.38757 + 0.70757\lambda^2 / (\lambda^2 - 0.00931) + 0.18849\lambda^2 / (\lambda^2 - 50.99741)$ $n_e^2 = 1.31021 + 0.84903\lambda^2 / (\lambda^2 - 0.00876) + 0.53607\lambda^2 / (\lambda^2 - 134.9566)$

Table 3. Index of Refraction

Wavelength (nm)	n_o	n_e
262	1.485	1.511
350	1.473	1.491
525	1.456	1.479
1050	1.448	1.47
2065	1.442	1.464

Table 4. dn / dT

Wavelength (nm)	$E \parallel c$	$E \perp c$
436	$-2.44 \times 10^{-6}/^\circ\text{C}$	$-0.54 \times 10^{-6}/^\circ\text{C}$
578	$-2.86 \times 10^{-6}/^\circ\text{C}$	$-0.91 \times 10^{-6}/^\circ\text{C}$
1060	$-4.30 \times 10^{-6}/^\circ\text{C}$	$-2.00 \times 10^{-6}/^\circ\text{C}$

Specifications of Nd:YLF crystal from CASTECH

Table 5. Specifications

Standard Dopant Concentration	Nd: $1.1 \pm 0.1\%$
Surface quality (scratch/dig)	10/5 to MIL-PRF-13830B
Wavefront Distortion	$\leq \lambda/4$ @633 nm
Surface Flatness	$\lambda/8$ @633 nm
Parallelism	20 arc sec
Perpendicularity	≤ 15 arc min
Chamfer	$\leq 0.2 \text{ mm} \times 45^\circ$
End Coating	R<0.15% @1047/1053 nm